N Channel MOSFET

Applications:

- Adapter & Charger
- SMPS Standby Power
- •AC-DC Switching Power Supply
- •LED driving power

Features:

- •Low On Resistance
- •Low Gate Charge

Part Number

RS18N50F

•Peak Current vs Pulse Width Curve

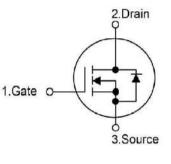
Package

TO-220F

RoHS Compliant

Ordering Information





Not to Scale

Absolute Maximun Ratings Tc=25°C unless otherwise specified

Marking

RS18N50F

Symbol	Parameter	RS18N50F	Units
VDSS	Drain-to-Source Voltage (Note*1)	500	V
ID	Continuous Drain Current	18.0	
ID@ 100 ℃	Continuous Drain Current	10.6	А
ldм	Pulsed Drain Current (Note*2)	72.0	
PD	Power Dissipation	98	W
VGS	Gate-to-Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L=10mH VDD=50V RG=25Ω Starting TJ=25℃	1280	mJ
IAS	(Note*2)	16	А
EAR	Repetitive Avalanche Energy	89	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

*Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RS18N50F	Units	Test Conditions
Rejc	Junction-to-Case	1.27		Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150℃.
RθJA	Junction-to-Ambient	60		1 cubic foot chamber, free air.

RS18N50F

Lead Free Package and Finish

lo	RDS(ON)(Typ.)	Vdss
18A	0.28Ω	500V

Pb



Static Characteristics TJ=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain-to-source Breakdown Voltage	500			V	Vgs=0V,Id=250µA
ldss	Drain-to-Source Leakage Current			1.0	μA	V _{DS} =500V,VGS=0V
	Gate-to-Source Forward Leakage			100	n۸	VGS=+30V VDS=0V
lgss	Gate-to-Source Reverse Leakage			-100	nA	Vgs=-30V Vds=0V

Static Characteristics TJ=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IRDS(on)	Static Drain-to-Source On-Resistance (Note*3)		0.28	0.33	Ω	V _{GS} =10V,I _D =9A
VGS(TH)	Gate Threshold Voltage	2.0		4.0	V	Vgs=Vds,Id =250µA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn-on Delay Time		35			Vps=250V
trise	Rise Time		50		nS	ID=18A
td(OFF)	Turn-OFF Delay Time		180		115	RG =25 Ω
tfall	Fall Time		65			

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		2148			VGS=0V
Coss	Output Capacitance		252		pF	VDS=25V
Crss	Reverse Transfer Capacitance		22			f=1.0MHz
Qg	Total Gate Charge		58.4			VDS=400V
Qgs	Gate-to-Source Charge		10.2		nC	I⊡=18A VGS=10V
Qgd	Gate-to-Drain("Miller") Charge		22.1			(Note:3,4)



Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current			18.0	Α	Integral pn-diode
lsм	Maximum Pulsed Current			72.0	Α	in MOSFET
Vsd	Diode Forward Voltage			1.4	V	IS=10A,VGS=0V
trr	Reverse Recovery Time		430		nS	VGS=0V
Qrr	Reverse Recovery Charge		6.5		μC	IS=18A,di/dt=100A/µs

Notes:

*1.TJ=±25℃ to +150℃.

*2.Repetitive rating; pulse width limited by maximum junction temperature.

*3.Pulse width \leq 300 µs; duty cycle \leq 1%.

Typical Feature curve T_J = 25°C, unless otherwise noted

Figure 1. Output Characteristics (TJ = 25°C)

Figure2. Body Diode Forward Voltage

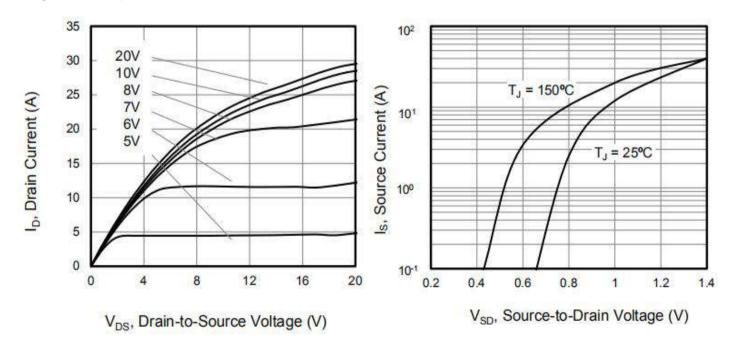
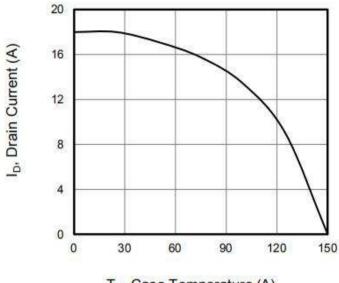




Figure 3. Drain Current vs. Temperature



T_c, Case Temperature (A)



Figure 4. BVDSS Variation vs. Temperature

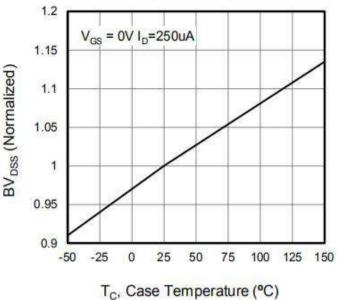
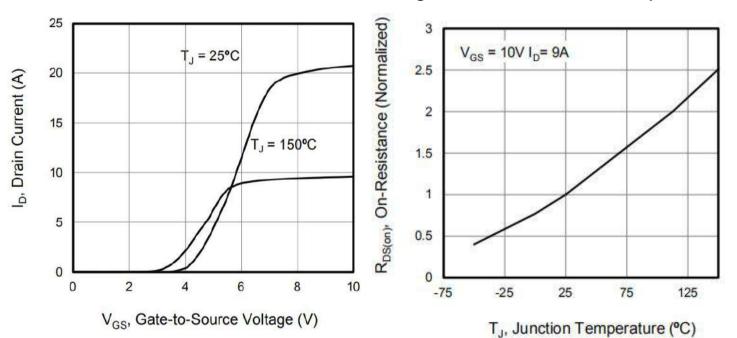
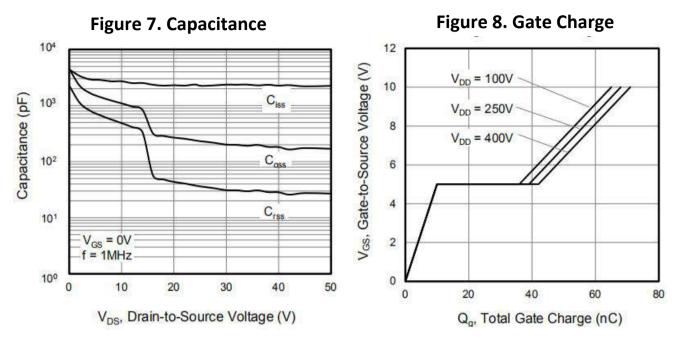
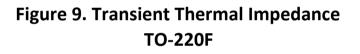


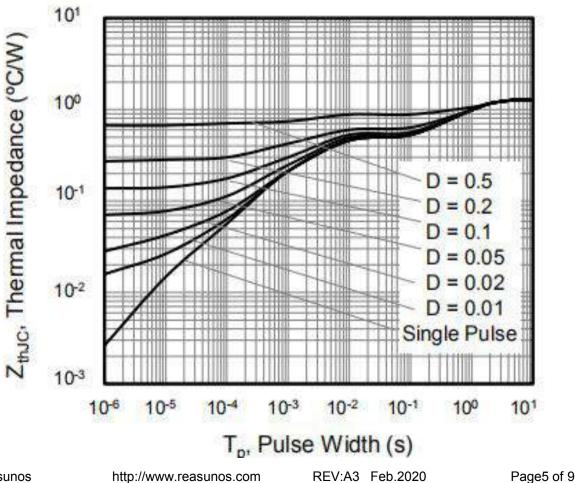
Figure 6. On-Resistance vs. Temperature













Test Circuits and Waveforms

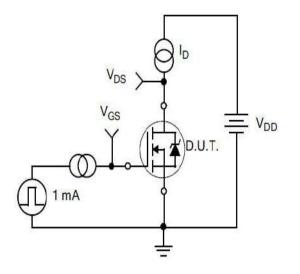


Figure10. Gate Charge Test Circuit

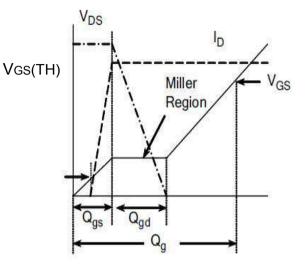


Figure11. Gate Charge Waveform

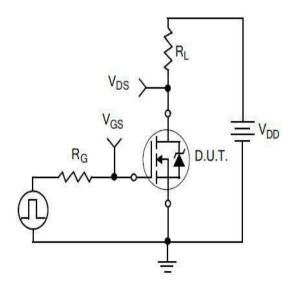


Figure12. Resistive Switching Test Circuit

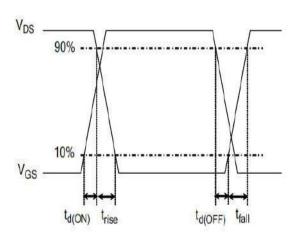
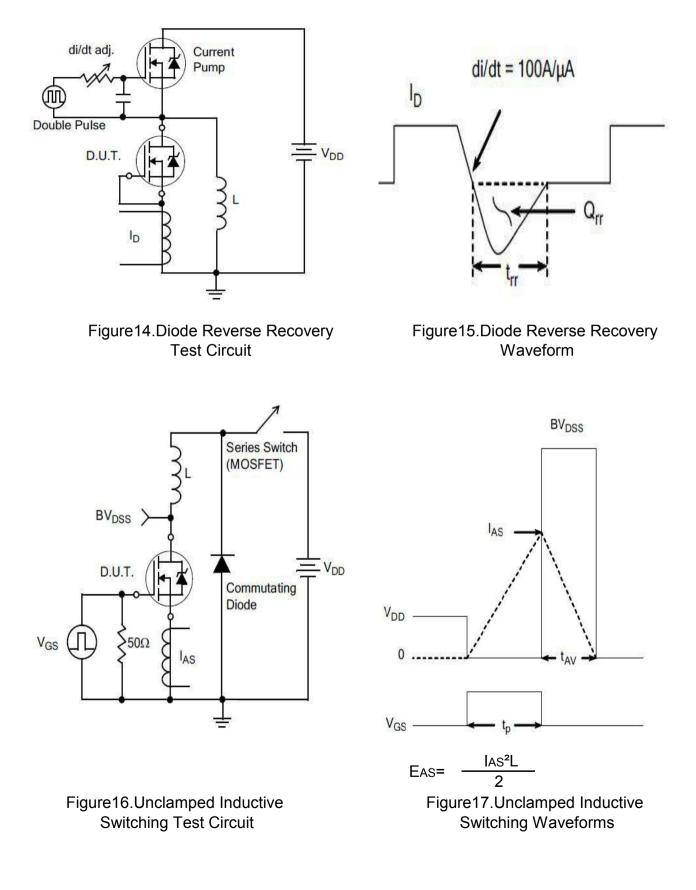


Figure13. Resistive Switching Waveforms

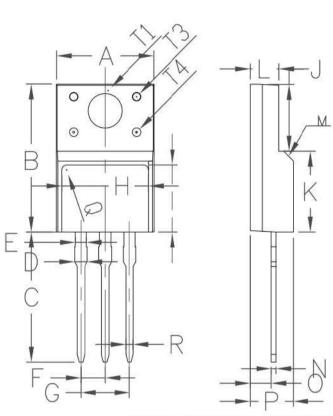


Test Circuits and Waveforms

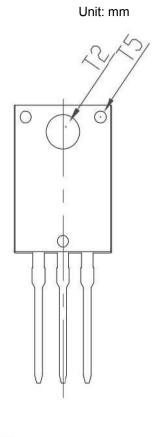




Package outline drawing



TO-220F



Symbol	Min	Non	Max
A	9.96	10.16	10.36
В	15.67	15.87	16.07
С	13.14	13.34	13.54
D	1.20	1.30	1.40
E		1.20	
F		2.54	
G		5.08	
H	7.60	7.80	8.00
I	7.10	7.30	7.50
J	6.48	6.68	6.88
K	8.99	9.19	9.39
L	2.34	2.54	2.74
M		45°	
N	0.49	0.50	0.52
0	2.15	2.35	2.55
Р	4.50	4.70	4.90
Q		0.50	
S	4°	4.5°	5°
T1		3.45	
T2		3.18	
T3		1.50	
T4		1.20	
T5		1.50	
R	0.77	0.8	0.83

http://www.reasunos.com



Disclaimers:

Reasunos Semiconductor Technology CO.,LTD(Reasunos)reserves the right to make changes without notice in order to improve reliability,function or design and to discontinue any product or service without notice .Customers should obtain the latest relevant information before orders and should verify that such information in current and complete.All products are sold subject to Reasunos's terms and conditions supplied at the time of order acknowledgement.

Reasunos Semiconductor Technology CO.,LTD warrants performance of its hardware products to the speciffications at the time of sale.Testing,reliability and quality control are used to the extene Reasunos deems necessary to support this warrantee. Except where agreed upon by contractual agreement,testing of all parameters of each product is not necessarily performed.

Reasunos Semiconductor Technology CO.,LTD does not assume any liability arising from the use of any product or circuit designs described herein.Customers are responsible for their products and applications using Reasunos's components.To minimize risk,customers must provide adequate design and operating safeguards.

Reasunos Semiconductor Technology CO.,LTD does not warrant or convey any license either expressed or implied under its patent rights,nor the rights of others.Reproduction of information in Reasunos's data sheeets or data books is permissible only if reproduction is without modification oralteration.Reproduction of this information with any alteration is an unfair and deceptive business practice. Reasunos Semiconductor Technology CO.,LTD is not responsible or liable for such altered documentation.

Resale of Reasunos's products with statements different from or beyond the parameters stated by Reasunos Semiconductor Technology CO.,LTD for that product or service voids all express or implied warrantees for the associated Reasunos's product or service and is unfair and deceptive business practice. Reasunos Semiconductor Technology CO.,LTD is not responsible or liable for such statements.

Life Support Policy:

Reasunos Semiconductor Technology CO.,LTD's Products are not authorized for use as critical components in life support devices or systems without the expressed written approval of Reasunos Semiconductor Technology CO.,LTD.

As used herein:

1.Life support devices or systems are devices or systems which:

a.are intended for surgical implant into the human body,

b.support or sustain life,

c.whose failuer to when properly used in accordance with instructions for used provided in the laeling,can be reasonably expected to result in significant injury to the user.

2.A critical component is any component of a life support device or system whose failure to system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.